

Notice of References Cited	Application/Control No. 10/606,376		Applicant(s)/Patent Under Reexamination CHOU ET AL.	
	Examiner Sharon E. Payne		Art Unit 2875	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,490,015	12-2002	Kim, Hyo Jin	349/58
	B	US-			
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	K	US-			
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	M	US-			

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NON-PATENT DOCUMENTS

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